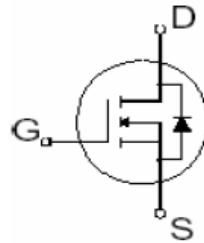




StarMOS^T Power MOSFET

- Extremely high dv/dt capability
- Low Gate Charge Qg results in Simple Drive Requirement
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatability

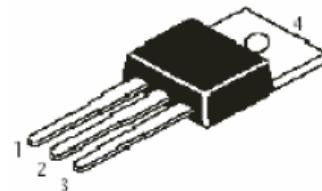


V_{DSS} = 400V
I_{D25} = 10A
R_{DS(ON)} = 0.53 Ω

Description

StarMOS is a new generation of high voltage N-Channel enhancement mode power MOSFETs. This new technology minimises the JFET effect, increases packing density and reduces the on-resistance. StarMOS also achieves faster switching speeds through optimised gate layout with planar stripe DMOS technology.

TO-220



Pin1-Gate
Pin2-Drain
Pin3-Source

Application

- Switching application

Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @T _c =25°C	Continuous Drain Current, V _{GS} @10V	10	A
I _D @T _c =100°C	Continuous Drain Current, V _{GS} @10V	6.5	
I _{DM}	Pulsed Drain Current ①	40	
P _D @T _c =25°C	Power Dissipation	135	W
	Linear Derating Factor	1.0	W/C
V _{GS}	Gate-to-Source Voltage	±20	V
E _{AS}	Single Pulse Avalanche Energy ②	630	mJ
I _{AR}	Avalanche Current ①	10	A
E _{AR}	Repetitive Avalanche Energy ①	12.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	6	V/ns
T _J	Operating Junction and	-55 to +175	C
T _{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300(1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf.in(1.1N.m)	

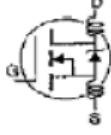
Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
R _{JC}	Junction-to-case	—	—	1.0	C/W
R _{CS}	Case-to-Sink, Flat, Greased Surface	—	0.50	—	
R _{JA}	Junction-to-Ambient	—	—	62	

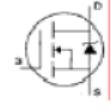


Typical Characteristics

Electrical Characteristics @ $T_J=25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	400	—	—	V	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp.Coefficient	—	0.48	—	V/C	Reference to $25^\circ\text{C}, I_D=1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-resistance	—	0.50	0.53	Ω	$V_{GS}=10\text{V}, I_D=6\text{A}$ ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$
g_{fs}	Forward Transconductance	4.9	—	—	S	$V_{DS}=50\text{V}, I_D=6\text{A}$
I_{LSS}	Drain-to-Source Leakage current	—	—	25	μA	$V_{DS}=400\text{V}, V_{GS}=0\text{V}$
		—	—	250		$V_{DS}=320\text{V}, V_{GS}=0\text{V}, T_J=150^\circ\text{C}$
I_{LSS}	Gate-to-Source Forward leakage	—	—	100	nA	$V_{GS}=20\text{V}$
	Gate-to-Source Reverse leakage	—	—	-100		$V_{GS}=-20\text{V}$
Q_g	Total Gate Charge	—	—	36	nC	$I_D=10\text{A}$
Q_{gs}	Gate-to-Source charge	—	—	10		$V_{DS}=320\text{V}$
Q_{gd}	Gate-to-Drain("Miller") charge	—	—	16		$V_{GS}=10\text{V}$ See Fig.6 and 13④
$t_{d(on)}$	Turn-on Delay Time	—	10	—	nS	$V_{DD}=200\text{V}$
t_r	Rise Time	—	35	—		$I_D=10\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	24	—		$R_G=10\Omega$
t_f	Fall Time	—	22	—		$R_D=19.5\Omega$
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm(0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	1012	—	pF	$V_{GS}=0\text{V}$
C_{oss}	Output Capacitance	—	170	—		$V_{DS}=25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	7.9	—		$f=1.0\text{MHz}$ See Figure 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	10	A	MOSFET symbol showing the integral reverse p-n junction diode. 
	Pulsed Source Current (Body Diode) ①	—	—	40		
V_{SD}	Diode Forward Voltage	—	—	1.8	V	$T_J=25^\circ\text{C}, I_S=10\text{A}, V_{GS}=0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	—	250	nS	$T_J=25^\circ\text{C}, I_F=10\text{A}$
Q_{rr}	Reverse Recovery Charge	—	2.5	—	nC	$dI/dt=100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-on Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

Notes:

- ① Repetitive rating pulse width limited by max.junction temperature(see figure 11)
- ② $L = 7.3\text{mH}$, $I_{AS} = 10\text{ A}$, $V_{DD} = 50\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$
- ③ $I_{SD} \leq 10\text{A}, dI/dt \leq 200\text{A}/\mu\text{s}, V_{DD} \leq V_{(BR)DSS}, T_J \leq 25^\circ\text{C}$
- ④ Pulse width $\leq 300\text{ }\mu\text{s}$; duty cycle $\leq 2\%$